

PC911

Ultra-high Speed Response and High CMR OPIC Photocoupler

※ Lead forming type (I type) and taping reel type (P type) are also available. (PC911I/PC911P)

■ Features

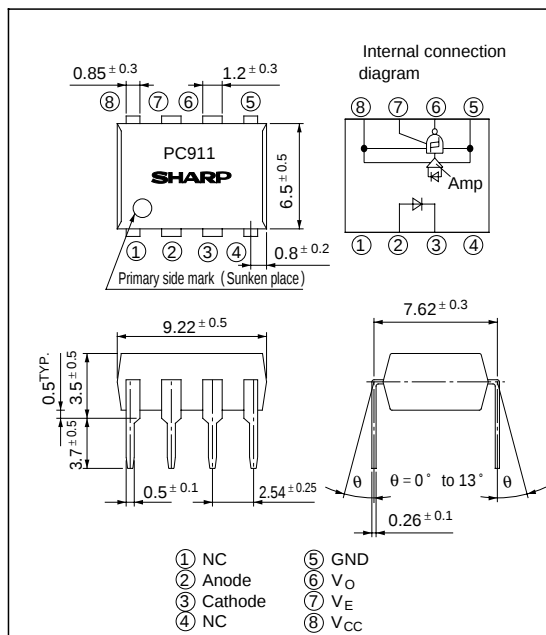
1. Ultra-high speed response
(t_{PHL} , t_{PLH} : TYP. 50ns)
2. High instantaneous common mode rejection voltage (CM_H : TYP. 10kV/ μ s)
3. High isolation voltage
(V_{iso} : 4 000V_{rms})
4. Recognized by UL, file No. E64380

■ Applications

1. High speed interfaces for computer peripherals and microcomputer systems
2. High speed line receivers
3. Interfaces with various data transmission equipment

■ Outline Dimensions

(Unit : mm)



* "OPIC" (Optical IC) is a trademark of the SHARP Corporation.
An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

■ Absolute Maximum Ratings

($T_a = 25^\circ\text{C}$)

Parameter	Symbol	Rating	Unit
Input	*1 Forward current	I_F	20 mA
	Reverse voltage	V_R	5 V
	*1 Power dissipation	P	40 mW
Output	Supply voltage	V_{CC}	7 V
	*2 Enable voltage	V_E	7 V
	High level output current	V_{OH}	- 8 mA
	Low level output current	I_{OL}	25 mA
	*1 *3 Power dissipation	P	40 mW
	*4 Isolation voltage	V_{iso}	4 000 V _{rms}
Operating temperature		T_{opr}	0 to + 70 $^\circ\text{C}$
Storage temperature		T_{stg}	- 55 to + 125 $^\circ\text{C}$
*5 Soldering temperature		T_{sol}	260 $^\circ\text{C}$

*1 $T_a = 0$ to 70°C

*2 Shall not exceed 500mV from supply voltage(V_{CC}).

*3 Applicable to output terminal(V_O)

*4 AC for 1 minute, 40 to 60% RH

*5 For 10 seconds at the position of 2mm or more from root of lead pins.

■ Electro-optical Characteristics

(Ta = 0 to 70°C unless specified)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	V_F	Ta = 25°C, $I_F = 10\text{mA}$	-	1.6	1.9	V
	Reverse current	I_R	Ta = 25°C, $V_R = 5\text{V}$	-	-	10	μA
	Terminal capacitance	C_t	Ta = 25°C, $V = 0$, $f = 1\text{MHz}$	-	60	120	pF
Output	High level output voltage	V_{OH}	$V_{CC} = 4.5\text{V}$, $I_{OH} = -2\text{mA}$, $I_F = 0.25\text{mA}$, $V_E = 0.2\text{V}$	2.4	-	-	V
	Low level output voltage	V_{OL}	$V_{CC} = 4.5\text{V}$, $V_E = 2.0\text{V}$, $I_F = 5\text{mA}$, $I_{OL} = 13\text{mA}$	-	0.3	0.6	V
	High level enable voltage	V_{EH}	$V_{CC} = 5.5\text{V}$	2.0	-	-	V
	Low level enable voltage	V_{EL}	$V_{CC} = 5.5\text{V}$	-	-	0.8	V
	High level enable current	I_{EH}	$V_{CC} = 5.5\text{V}$, $V_E = 5.5\text{V}$	-	-	100	μA
	Low level enable current	I_{EL}	$V_{CC} = 5.5\text{V}$, $V_E = 0.5\text{V}$	-	- 0.2	- 0.4	mA
	High level supply current	I_{CCH}	$V_{CC} = 5.5\text{V}$, $I_F = 0$, $V_E = 2.0\text{V}$	-	13	23	mA
	Low level supply current	I_{CCL}	$V_{CC} = 5.5\text{V}$, $I_F = 10\text{mA}$, $V_E = 2.0\text{V}$	-	15	25	mA
	High impedance supply current	I_{CCZ}	$V_{CC} = 5.5\text{V}$, $V_E = 0$	-	16	26	mA
	Output leak current	I_{OH}	$V_{CC} = 5.5\text{V}$, $V_E = 2.0\text{V}$, $V_0 = 5.5\text{V}$, $I_F = 0.25\text{mA}$	-	-	100	μA
	High impedance output current	I_{OZH}	$V_{CC} = 5.5\text{V}$, $V_E = 0.4\text{V}$	-	-	100	μA
Transfer characteristics	Output short-circuit current	I_{OS}	$V_{CC} = 5.5\text{V}$, $V_0 = 0$, $I_F = 0$, within 10ms.	- 10	-	- 50	mA
	“High→Low” threshold input current	I_{FHL}	$V_{CC} = 5\text{V}$, $V_E = 2.0\text{V}$	-	2.5	5	mA
	“Low→High” threshold input current	I_{FLH}	$V_{CC} = 5\text{V}$, $V_E = 2.0\text{V}$	0.5	1.9	-	mA
	Hysteresis	I_{FLH} / I_{FHL}	$V_{CC} = 5\text{V}$, $V_E = 2.0\text{V}$	0.55	-	0.95	-
	Isolation resistance	R_{ISO}	Ta = 25°C, DC500V, 40 to 60% RH	5×10^{10}	10^{11}	-	Ω
	Floating capacitance	C_f	Ta = 25°C, $V = 0$, $f = 1\text{MHz}$	-	0.6	5	pF
	Response characteristics	“High→Low” propagation delay time	Ta = 25°C, $V_{CC} = 5\text{V}$ $C_L = 15\text{pF}$ $I_F = 7.5\text{mA}$, Fig. 1	-	50	75	ns
		“Low→High” propagation delay time		-	50	75	ns
		*6 Pulse width distortion		-	-	35	ns
		Rise time, Fall time		-	15	30	ns
		“High→Low” enable propagation delay time	Ta = 25°C, $V_{CC} = 5\text{V}$ $R_L = 350\Omega$, $C_L = 15\text{pF}$ $I_F = 7.5\text{mA}$, $V_{EH} = 3\text{V}$ $V_{EL} = 0$, Fig. 2	-	40	70	ns
		“Low→High” enable propagation delay time		-	40	70	ns
CMR	Instantaneous common mode rejection voltage “output : High level”	CM_H	Ta = 25°C, $V_{CC} = 5\text{V}$, $V_{CM} = 50\text{V}$ $I_F = 0\text{mA}$, $V_{O(MIN.)} = 2\text{V}$, Fig. 3	3 000	10 000	-	V/ μs
	Instantaneous common mode rejection voltage “output : Low level”	CM_L	Ta = 25°C, $V_{CC} = 5\text{V}$, $V_{CM} = 50\text{V}$ $I_F = 5\text{mA}$, $V_{O(MAX.)} = 0.8\text{V}$, Fig. 3	- 3 000	- 10 000	-	V/ μs

 *6 $\Delta T_W = t_{PHL} - t_{PLH}$

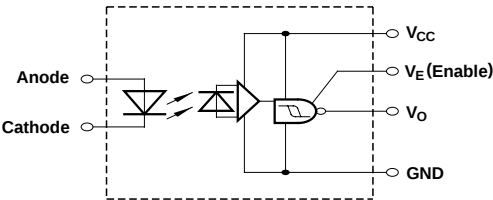
 All typical values : at Ta = 25°C, $V_{CC} = 5\text{V}$

■ Recommended Operating Conditions

Parameter	Symbol	MIN.	MAX.	Unit
Low level input current	I_{FL}	0	250	μA
High level input current	I_{FH}	7	15	mA
High level enable voltage	V_{EH}	2.0	V_{CC}	V
Low level enable voltage	V_{EL}	0	0.8	V
Supply voltage	V_{CC}	4.5	5.5	V
Fanout (TTL load)	N	-	8	-
Operating temperature	T_{opr}	0	70	$^{\circ}C$

1. When the enable input is not used, please connect to V_{CC} .
2. In order to stabilize power supply line, connect a by-pass ceramic capacitor (0.01 to 0.1 μF) between V_{CC} and GND at the position within 1cm from pin.

Block Diagram



Truth table

Input	Enable	Output
H	H	L
L	H	H
H	L	Z
L	L	Z

L : Logic (0)
H : Logic (1)
Z : High impedance

Fig. 1 Test Circuit for t_{PHL} , t_{PLH} , t_r and t_f

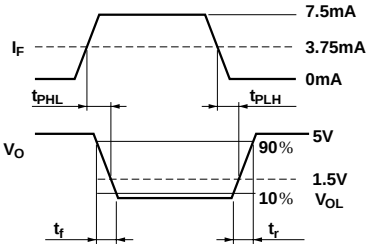
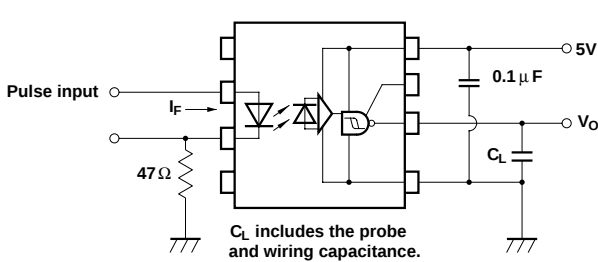


Fig. 2 Test Circuit for t_{EHL} and t_{ELH}

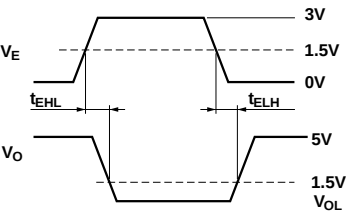
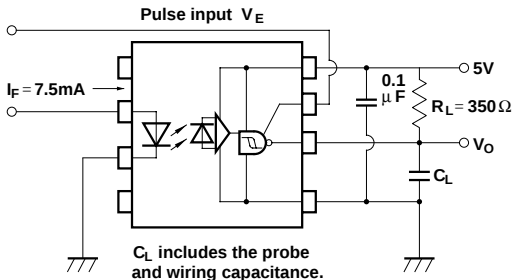


Fig. 3 Test Circuit for CM_H and CM_L

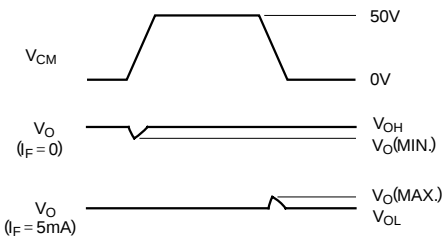
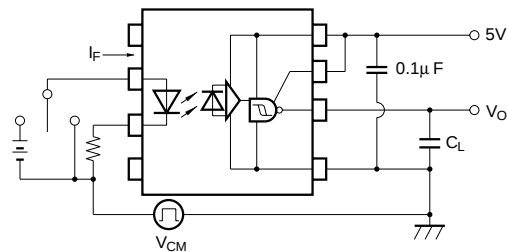


Fig. 4 Forward Current vs. Forward Voltage

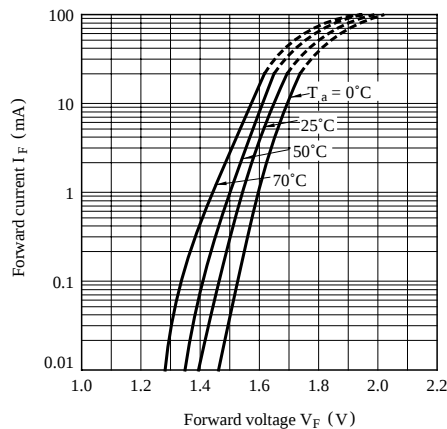


Fig. 5 Low Level Output Voltage vs. Low Level Output Current

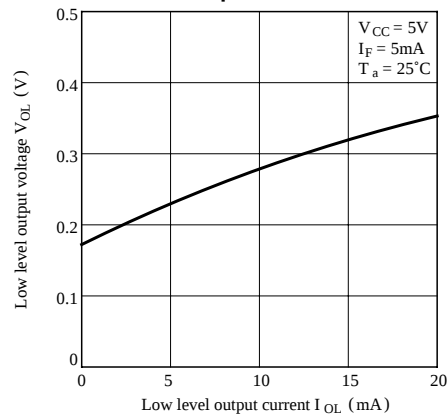


Fig. 6 High Level Output Voltage vs. High Level Output Current

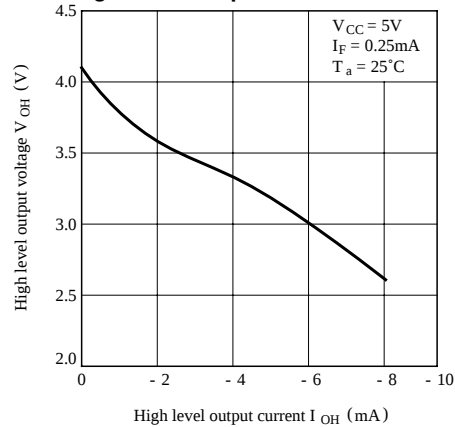


Fig. 7 Propagation Delay Time vs. Ambient Temperature

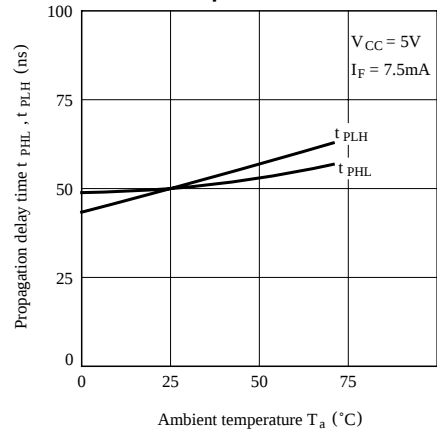
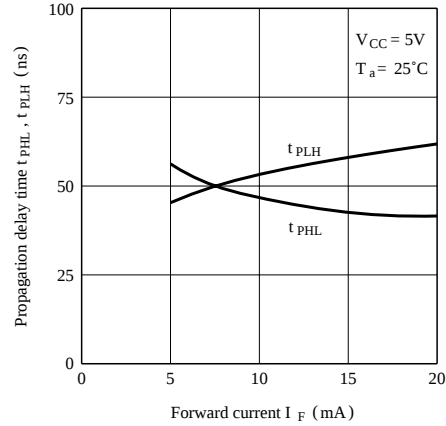


Fig. 8 Propagation Delay Time vs.
Forward Current



● Please refer to the chapter “Precautions for Use ”